

Sheet 1 of 1 ATTORNEY DOCKET NO. U.S. DEPARTMENT OF COMMERCE FORM PTO-1449 PATENT AND TRADEMARK OFFICE 10/622,469 1075.1233 FIRST NAMED INVENTOR LIST OF REFERENCES CITED BY APPLICANT Isao IWAGUCHI, et al. GROUP ART UNIT FILING DATE (Use several sheets if necessary) 28U. July 21, 2003 U.S. PATENT DOCUMENTS FILING SUB-DOCUMENT *EXAMINER **CLASS** DATE **CLASS** NAME NO. INITIAL DATE AA AB AC AD AE AF FOREIGN PATENT DOCUMENTS TRANSLATION SUB-DOCUMENT YES NO **CLASS** CLASS COUNTRY NO. DATE AG AH ΑI AJ AK ÂL TRANSLATION OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) YES NO English translation of PCT International Preliminary Examination Report, ΑM dated February 5, 2003, for International Application PCT/JP02/00533. DATE CONSIDERED **EXAMINER**

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through

citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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